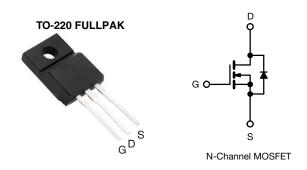
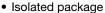
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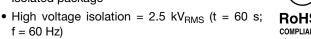
Power MOSFET



PRODUCT SUMMARY					
V _{DS} (V)	500				
$R_{DS(on)}(\Omega)$	V _{GS} = 10 V 3.0				
Q _g (Max.) (nC)	24				
Q _{gs} (nC)	3.3				
Q _{gd} (nC)	13				
Configuration	Single				

FEATURES





- Sink to lead creepage distance = 4.8 mm
- Dynamic dV/dt rating
- · Low thermal resistance
- Material categorization: for definitions of compliance please see <u>www.vishay.com/doc?99912</u>

DESCRIPTION

Third generation power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The molding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. The isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION	
Package	TO-220 FULLPAK
Lead (Pb)-free	IRFI820GPbF

ABSOLUTE MAXIMUM RATINGS $T_C = 25$ °C, unless otherwise noted					
PARAMETER			SYMBOL	LIMIT	UNIT
Drain-source voltage			V_{DS}	500	V
Gate-source voltage			V_{GS}	± 20	
Continuous drain current	V _{GS} at 10 V	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$	- I _D	2.1	
Continuous drain current		T _C = 100 °C		1.3	Α
Pulsed drain current ^a			I _{DM}	8.4	
Linear derating factor				0.24	W/°C
Single pulse avalanche energy b			E _{AS}	110	mJ
Repetitive avalanche current a			I _{AR}	2.1	Α
Repetitive avalanche energy ^a			E _{AR}	3.0	mJ
Maximum power dissipation $T_C = 25 ^{\circ}C$		P_{D}	30	W	
Peak diode recovery dV/dt ^c			dV/dt	3.5	V/ns
Operating junction and storage temperature range			T _J , T _{stg}	-55 to +150	
Soldering recommendations (peak temperature) ^d	For	10 s		300	°C
Mounting torque	M3 s	screw		0.6	Nm

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. $V_{DD} = 50 \text{ V}$, starting $T_J = 25 \,^{\circ}\text{C}$, $L = 44 \, \text{mH}$, $R_G = 25 \, \Omega$, $I_{AS} = 2.1 \, \text{A}$ (see fig. 12)
- c. $I_{SD} \le 2.1$ A, $dI/dt \le 50$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C
- d. 1.6 mm from case

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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum junction-to-ambient	R _{thJA}	-	65	°C/W	
Maximum junction-to-case (drain)	R _{thJC}	-	4.1	C/VV	

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static		•					
Drain-ssource breakdown voltage	V_{DS}	$V_{GS} = 0$	V, I _D = 250 μA	500	-	-	V
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	Reference t	to 25 °C, I _D = 1 mA	-	0.59	-	V/°C
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{C}$	_{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-source leakage	I _{GSS}	V _G	_S = ± 20 V	-	-	± 100	nA
7 la distribution and		V _{DS} = 50	00 V, V _{GS} = 0 V	-	-	25	μΑ
Zero gate voltage drain current	I _{DSS}	V _{DS} = 400 V, V	_{GS} = 0 V, T _J = 125 °C	-	-	250	
Drain-source on-state resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 1.3 A ^b	-	-	3.0	Ω
Forward transconductance	9fs	V _{DS} = 5	0 V, I _D = 1.3 A ^b	1.5	-	-	S
Dynamic							
Input capacitance	C _{iss}		$V_{GS} = 0 V$,		360	-	
Output capacitance	C _{oss}	V	os = 25 V,	-	92	-	_
Reverse transfer capacitance	C _{rss}	f = 1.0 I	f = 1.0 MHz, see fig. 5		37	-	pF
Drain to sink capacitance	С	f =	= 1.0 MHz	-	12	-	1
Total gate charge	Qg			-	-	24	nC
Gate-source charge	Q _{gs}	V _{GS} = 10 V	$I_D = 2.1 \text{ A}, V_{DS} = 400 \text{ V},$ see fig. 6 and 13 ^b	-	-	3.3	
Gate-drain charge	Q _{gd}	1	See lig. 6 and 135	-	-	13	
Turn-on delay time	t _{d(on)}	$V_{DD} = 250 \text{ V, } I_D = 2.1 \text{ A },$ $R_G = 18 \Omega, R_D = 120 \Omega, \text{ see fig. } 10^b$		-	8.0	-	- ns
Rise time	t _r			-	8.6	-	
Turn-off delay time	t _{d(off)}			-	33	-	
Fall time	t _f			-	16	-	
Internal drain inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	
Internal source inductance	L _S			-	7.5	-	- nH
Drain-Source Body Diode Characteristic	es						I
Continuous source-drain diode current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	2.1	А
Pulsed diode forward current ^a	I _{SM}			-	-	8.0	A
Body diode voltage	V _{SD}	T _J = 25 °C, I _S	T _J = 25 °C, I _S = 2.1 A, V _{GS} = 0 V ^b		-	1.6	V
Body diode reverse recovery time	t _{rr}	T - 25 °C 1	0 1 A dl/dt = 100 A/··-b	-	260	520	ns
Body diode reverse recovery charge	Q _{rr}	$T_J = 25 ^{\circ}\text{C}, I_F = 2.1 \text{A}, dI/dt = 100 \text{A}/\mu\text{s}^{\text{b}}$		-	0.70	1.4	μC
Forward turn-on time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D)				L _D)	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. Pulse width \leq 300 µs; duty cycle \leq 2 %



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

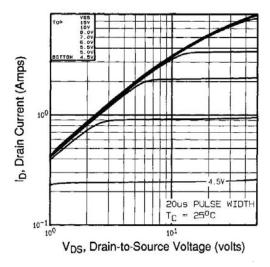


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

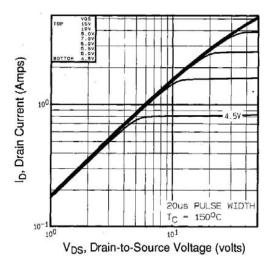


Fig. 2 - Typical Output Characteristics, $T_C = 150$ °C

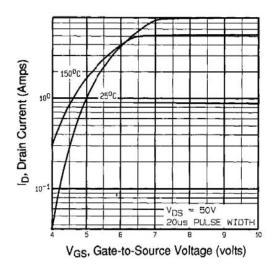


Fig. 3 - Typical Transfer Characteristics

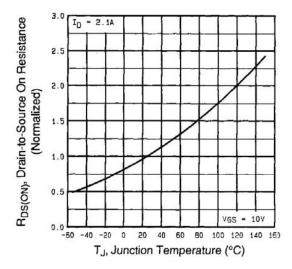


Fig. 4 - Normalized On-Resistance vs. Temperature



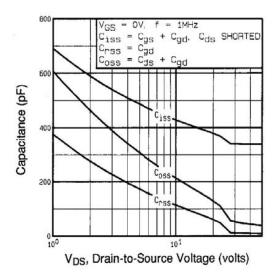


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

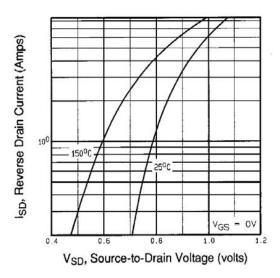


Fig. 7 - Typical Source-Drain Diode Forward Voltage

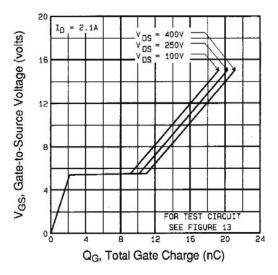


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

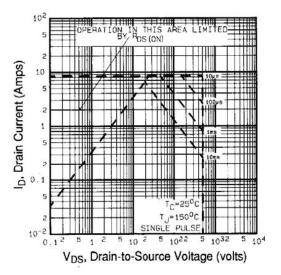


Fig. 8 - Maximum Safe Operating Area



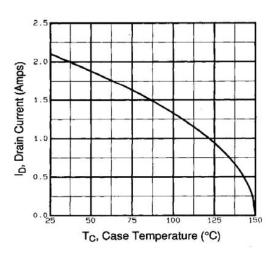


Fig. 9 - Maximum Drain Current vs. Case Temperature

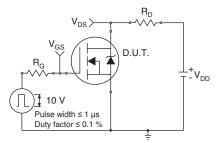


Fig. 10a - Switching Time Test Circuit

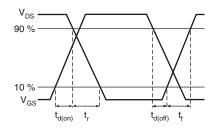


Fig. 10b - Switching Time Waveforms

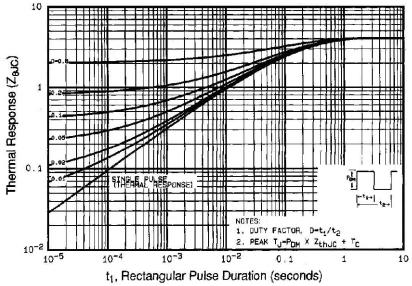
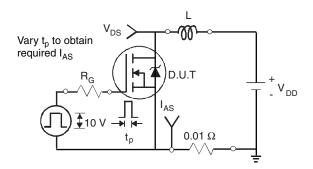


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case





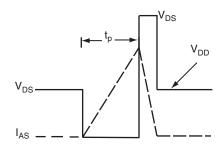


Fig. 12a - Unclamped Inductive Test Circuit

Fig. 12b - Unclamped Inductive Waveforms

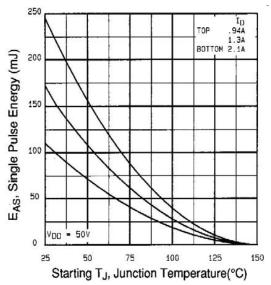


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

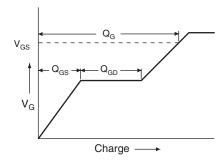


Fig. 13a - Basic Gate Charge Waveform

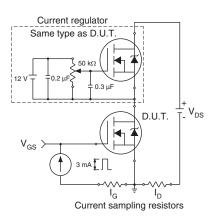
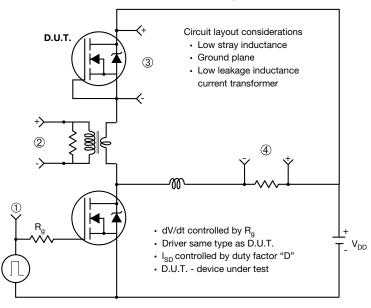


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



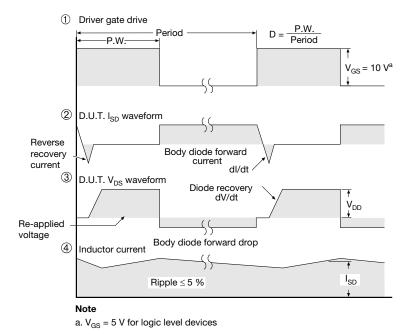


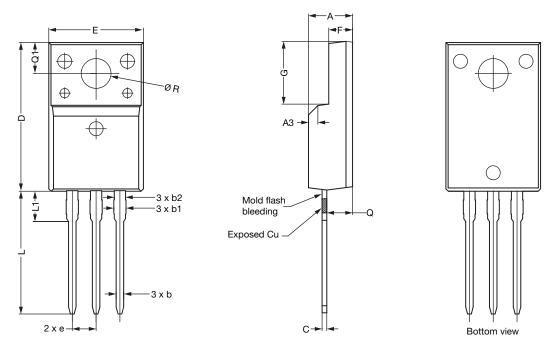
Fig. 14 - For N-Channel

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?91158.

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TO-220 FULLPAK (High Voltage)

OPTION 1: FACILITY CODE = 9

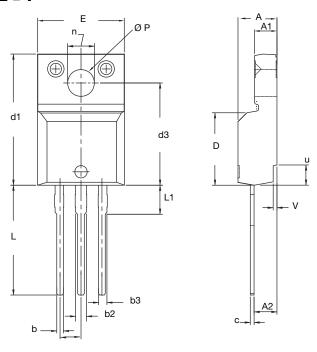


	MILLIMETERS			
DIM.	MIN.	NOM.	MAX.	
A	4.60	4.70	4.80	
b	0.70	0.80	0.91	
b1	1.20	1.30	1.47	
b2	1.10	1.20	1.30	
С	0.45	0.50	0.63	
D	15.80	15.87	15.97	
е	2.54 BSC			
E	10.00	10.10	10.30	
F	2.44	2.54	2.64	
G	6.50	6.70	6.90	
L	12.90	13.10	13.30	
L1	3.13	3.23	3.33	
Q	2.65	2.75	2.85	
Q1	3.20	3.30	3.40	
ØR	3.08	3.18	3.28	

- 1. To be used only for process drawing
- 2. These dimensions apply to all TO-220 FULLPAK leadframe versions 3 leads
- 3. All critical dimensions should C meet $C_{pk} > 1.33$
- 4. All dimensions include burrs and plating thickness
- 5. No chipping or package damage
- 6. Facility code will be the 1st character located at the 2nd row of the unit marking



OPTION 2: FACILITY CODE = Y



	MILLIMETERS		INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
А	4.570	4.830	0.180	0.190	
A1	2.570	2.830	0.101	0.111	
A2	2.510	2.850	0.099	0.112	
b	0.622	0.890	0.024	0.035	
b2	1.229	1.400	0.048	0.055	
b3	1.229	1.400	0.048	0.055	
С	0.440	0.629	0.017	0.025	
D	8.650	9.800	0.341	0.386	
d1	15.88	16.120	0.622	0.635	
d3	12.300	12.920	0.484	0.509	
Е	10.360	10.630	0.408	0.419	
е	2.54	BSC	0.100 BSC		
L	13.200	13.730	0.520	0.541	
L1	3.100	3.500	0.122	0.138	
n	6.050	6.150	0.238	0.242	
ØP	3.050	3.450	0.120	0.136	
u	2.400	2.500	0.094	0.098	
V	0.400	0.500	0.016	0.020	
ECN: E10 0190 Pov D (00 Apr 2010	•			

ECN: E19-0180-Rev. D, 08-Apr-2019

DWG: 5972

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- 2. These dimensions apply to all TO-220 FULLPAK leadframe versions 3 leads
- 3. All critical dimensions should C meet $C_{pk} > 1.33$
- 4. All dimensions include burrs and plating thickness
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- 6. Facility code will be the 1st character located at the 2nd row of the unit marking



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